

Notice of References Cited

Application/Control No.

10/573,627

Applicant(s)/Patent Under
Reexamination
ROEHM ET AL.

Examiner

M'baye Diao

Art Unit

2838

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,364,033	04-2002	Hung et al.	173/217
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	W	
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